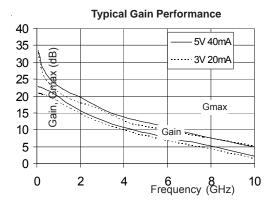


## **Product Description**

Sirenza Microdevices' SPF-3143Z is a high performance 0.5μm pHEMT Gallium Arsenide FET. This 600µm device is ideally biased at 3V, 20mA for lowest noise performance and battery powered requirements. At 5V, 40mA the device can deliver OIP3 of 32.5 dBm. It provides ideal performance as a driver stage in many commercial and industrial LNA

The matte tin finish on Sirenza's lead-free package utilizes a post annealing process to mitigate tin whisker formation and is RoHS compliant per EU Directive 2002/95. This package is also manufactured with green molding compounds that contain no antimony trioxide nor halogenated fire retardants.



# **SPF-3143Z**



## Low Noise pHEMT GaAs FET



#### **Product Features**

- Available in Lead free, RoHS compliant, & Green packaging
- DC-3.5 GHz Operation

- 0.58 dB NF<sub>MIN</sub> @ 2 GHz 21 dB G<sub>MAX</sub> @ 2 GHz +31 dBm OIP3 (5V,40mA)
- +17.7 dBm P1dB (5V,40mA)
- Low Current, Low Cost
- Apps circuits available for key bands

## **Applications**

- · Analog and Digital Wireless Systems
- 3G, Cellular, PCS
- **Fixed Wireless, Pager Systems**
- **Driver Stage for Low Power Applications**

Symbol	Parameters	Test Conditions V <sub>DS</sub> =5V, I <sub>DQ</sub> =40mA, 25C (unless otherwise noted)	Units	Test Frequency (GHz)	Min.	Тур.	Max.
$G_MAX$	Maximum Available Gain	$Z_{S}=Z_{S}^{*}, Z_{I}=Z_{I}^{*}$	dB	0.9		23.3	
→ <sub>MAX</sub>	Waximum Available Gain	25 25 , 2L 2L	uВ	1.9		19.9	
NF <sub>MIN</sub>	Minimum Noise Figure	$Z_S = \Gamma_{OPT}, Z_L = Z_L^*$	dB	0.9		0.36	
MIN	William Noise Figure	25 10pl, 2L 2L	QD.	1.9		0.58	
S <sub>21</sub>	Insertion Gain	$Z_S=Z_L=50\Omega$	dB	0.9	18.2	19.7	21.2
NF	Noise Figure	Application Circuit	dB	1.9		8.0	1.0
Gain	Gain	Application Circuit	dB	1.9	14.1	15.6	17.1
OIP <sub>3</sub>	Output Third Order Intercept Point	Application Circuit, Tone Spacing = 1MHz, Pout per tone = 0 dBm	dBm	1.9	30.5	32.5	
P <sub>1dB</sub>	Output Power at 1dB Compression	Application Circuit		1.9	19.0	20.5	
$V_P$	Pinchoff Voltage	$V_{DS} = 2V, I_{DS} = 0.6mA$	V		-1.4	-1.0	-0.6
I <sub>DSS</sub>	Saturated Drain Current	$V_{DS} = 2V$ , $V_{GS} = 0$ V	mA			180	
g <sub>m</sub>	Transconductance	$V_{DS} = 2V$ , $V_{GS} = 0 V$	mS			210	
BVGSO	Gate-Source Breakdown Voltage	I <sub>GS</sub> = 300 μA, drain open	V			-10	-7
BVGDO	Gate-Drain Breakdown Voltage	I <sub>GD</sub> = 300 μA, source open	V			-12	-7
$V_{DS}$	Device Operating Voltage	drain-source	V				5.5
I <sub>DS</sub>	Device Operating Current	drain-source	mA		38	40	42
R <sub>TH</sub> , j-l	Thermal Resistance (junction - lead)	junction to lead	°C/W			200	

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#### SPF-3143Z Low Noise pHEMT GaAs FET

#### **Junction Temperature Calculation**

MTTF is inversely proportional to the device junction temperature. For junction temperature and MTTF considerations the device operating conditions should also satisfy the following expression:

$$P_{DC} < (T_J - T_L) / R_{TH}$$

where:

 $P_{DC} = I_{DS} * V_{DS} (W)$   $T_{J} = Junction Temperature (C)$ T<sub>L</sub> = Lead Temperature (pin 2) (C) R<sub>TH</sub> = Thermal Resistance (C/W)

## **Biasing Details**

The SPF-3143Z is a depletion mode FET and requires a negative gate voltage to achieve pinchoff. As such, power supply sequencing circuitry is strongly recommended to prevent damaging bias transients during turn-on. Active bias circuitry is also recommended to maintain a constant drain current from part-to-part.

#### **Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit
Drain Current	I <sub>DSS</sub>	180	mA
Forward Gate Current	l <sub>GSF</sub>	600	μΑ
Reverse Gate Current	I <sub>GSR</sub>	600	μΑ
Drain-to-Source Voltage	V <sub>DS</sub>	7	V
Gate-to-Source Voltage	V <sub>GS</sub>	<-3 OR >0	V
RF Input Power	P <sub>IN</sub>	15	dBm
Storage Temperature Range	T <sub>stor</sub>	-40 TO +150	С
Power Dissipation	P <sub>DISS</sub>	325	mW
Junction Temperature	T <sub>J</sub>	+150	С

Operation of this device beyond any one of these limits may cause permanent damage. For reliable continuous operation, the device voltage and current must not exceed the maximum operating values specified in the table on page 1.

### Peak RF Performance Under Optimum Matching Conditions

Freq (GHz)	V <sub>DS</sub> (V)	I <sub>DQ</sub> (mA)	NF <sub>MIN</sub> <sup>[1]</sup> (dB)	Gmax (dB)	P1dB <sup>[2]</sup> (dBm)	OIP3 [3] (dBm)	
0.90	3	20	0.25	21.5	15	29	D
0.90	5	40	0.36	23.3	18	31	GZ <sub>LOPT</sub>
1.90	3	20	0.50	18.3	15	29	
1.90	5	40	0.58	19.1	18	31	Z <sub>SOPT</sub> S

 $<sup>^{[1]}</sup>$   $Z_s = \Gamma_{OPT}$ ,  $Z_t = Z_t^*$ , The input matching circuit losses have been de-emebedded.  $^{[2]}$   $Z_s = Z_{SOPT}$ ,  $Z_t = Z_{LOPT}$ , where  $Z_{SOPT}$  and  $Z_{LOPT}$  have been tuned for max P1dB

## Typical Performance - Noise Parameters

Freq (GHz)	V <sub>DS</sub> (V)	I <sub>DS</sub> (mA)	NF <sub>MIN</sub> <sup>[4]</sup> (dB)	Γ <sub>οΡΤ</sub> Mag ∠ Ang	r <sub>N</sub>	Gmax (dB)
0.90	3	20	0.25	0.70 ∠ 12.1	0.14	21.5
	5	40	0.36	0.66 ∠ 12.6	0.14	23.3
1.90	3	20	0.50	0.46 ∠ 26.4	0.13	18.3
	5	40	0.58	0.38 ∠ 28.1	0.13	19.1

<sup>[4]</sup>  $Z_s$ =Γ<sub>ΟΡΤ</sub>,  $Z_t$ = $Z_t$ \*, NF<sub>MIN</sub> is a noise parameter for which the input matching circuit losses have been de-emebedded. The device was mounted on a 0.010" PCB with plated-thru holes close to pins 2 and 4.



Caution: ESD sensitive

Appropriate precautions in handling, packaging and testing devices must be observed. ESD class rating 1B.

MSL (Moisture Sensitivity Level) Rating: Level 1

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 $<sup>^{[3]}</sup>$   $Z_s^{=}Z_{SOPT}^{-}$ ,  $Z_L^{=}Z_{LOPT}^{-}$ , where  $Z_{SOPT}^{-}$  and  $Z_{LOPT}^{-}$  have been tuned for max OIP3 Note: Optimum NF, P1dB, and OIP3 performance cannot be achieved simultaneously.

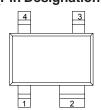


## SPF-3143Z Low Noise pHEMT GaAs FET

#### **Pin Description**

Pin #	Function	Description
1	Gate	RF Input / Gate Bias
2	Source	Connection to ground. Use via holes to reduce lead inductance. Place vias as close to ground leads as possible.
3	Drain	RF Output / Drain Bias
4	Source	No Connection / Recommend grounding pin

# **Pin Designation**



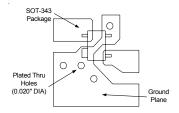
## **Part Number Ordering Information**

Part Number	Reel Size	Devices/Reel
SPF-3143Z	7"	3000

#### Part Symbolization

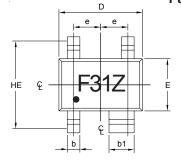
The part will be symbolized with the "F31Z" designator and a dot signifying pin 1 on the top surface of the package.

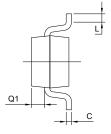
## **Recommended PCB Layout**

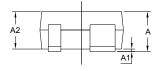


Use multiple plated-through vias holes located close to the package pins to ensure a good RF ground connection to a continuous groundplane on the backside of the board.

## **Package Dimensions**







- ALL DIMENSIONS ARE IN MILLIMETERS.
   DIMENSIONS ARE INCLUSIVE OF PLATING.
   DIMENSIONS ARE EXCLUSIVE OF MOLD FLASH
- 3. DIMENSIONS ARE EXACLOSIVE OF INFOCE TEXTS.

  8. METAL BURR.

  4. ALL SPECIFICATIONS COMPLY TO EIAJ SC70.

  5. DIE IS FACING UP FOR MOLD AND FACING DOWN
  FOR TRIMFORM. IE :REVERSE TRIMFORM.

  6. PACKAGE SURFACE TO BE MIRROR FINISH.

SYMBOL	NOM
E	1.25
D	2.05
HE	2.10
Α	1.05
A2	0.90
A1	0.05
Q1	0.25
е	0.65
b	0.375
b1	0.675
С	0.14
L	0.20